


<b>Search Notes</b> 	<b>Application/Control No.</b> 10541245	<b>Applicant(s)/Patent Under Reexamination</b> KUSUBAYASHI, CHIYO
	<b>Examiner</b> Hal I Kaplan	<b>Art Unit</b> 2836

SEARCHED			
Class	Subclass	Date	Examiner
307	9.1	4/12/2009	HK
307	26	4/12/2009	HK
307	28	4/12/2009	HK
307	29	4/12/2009	HK
307	45	4/12/2009	HK
307	75	4/12/2009	HK
307	83	4/12/2009	HK
307	145	4/12/2009	HK
191	2	4/12/2009	HK
191	4	4/12/2009	HK
191	8	4/12/2009	HK
191	23A	4/12/2009	HK
363	51	4/12/2009	HK
180	65.1	4/12/2009	HK
307	82	2/25/2010	HK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	4/12/2009	HK
307/9.1,26,28-29,45,75,83,145; 191/2,4,8,23A; 363/51; 180/65.1 (updated search)	10/29/2009	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout (updated search)	10/29/2009	HK
307/9.1,26,28-29,45,75,83,145; 191/2,4,8,23A; 363/51; 180/65.1 (updated search)	2/25/2010	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout (updated search)	2/25/2010	HK
Inventor name search	2/25/2010	HK
191/\$ (no search) - consulted Mark Le	2/25/2010	HK

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**INTERFERENCE SEARCH**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
307	9.1,26,28-29,45,75,82-83,145	2/25/2010	HK
191	2,4,8,23A	2/25/2010	HK
363	51	2/25/2010	HK
180	65.1	2/25/2010	HK

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